# **N-Channel Power MOSFET**

600V, 7A, 0.6Ω

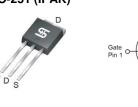
#### FEATURES

- Super-Junction technology
- High performance due to small figure-of-merit
- High ruggedness performance
- High commutation performance
- Pb-free plating
- Compliant to RoHS Directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

#### APPLICATIONS

- Power Supply
- Lighting

TO-251 (IPAK)



<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25°C unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	600	V	
Gate-Source Voltage		$V_{GS}$	±30	V	
Continuous Drain Current (Note 1)	T <sub>C</sub> = 25°C		7		
	$T_{\rm C} = 100^{\circ}{\rm C}$		4.4	A	
Pulsed Drain Current (Note 2)		I <sub>DM</sub>	21	А	
Total Power Dissipation @ $T_c = 25^{\circ}C$		P <sub>DTOT</sub>	63	W	
Single Pulsed Avalanche Energy (Note 3)		E <sub>AS</sub>	36	mJ	
Single Pulsed Avalanche Current (Note 3)		I <sub>AS</sub>	1.2	А	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	- 55 to +150	°C	

THERMAL PERFORMANCE				
PARAMETER	SYMBOL	DPAK	IPAK	UNIT
Junction to Case Thermal Resistance	$R_{\Theta JC}$	2		°C/W
Junction to Ambient Thermal Resistance	R <sub>eja</sub>	62	2	°C/W

**Thermal Performance Note:**  $R_{\Theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins.  $R_{\Theta JA}$  is guaranteed by design while  $R_{\Theta CA}$  is determined by the user's board design.  $R_{\Theta JA}$  shown below for single device operation on FR-4 PCB in still air.

KEY PERFORMANCE PARAMETERS				
PARAMETER VALUE UNIT				
V <sub>DS</sub>	600	V		
R <sub>DS(on)</sub> (max)	0.6	Ω		
Qg	13	nC		



## TSM60NB600CH



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PARAMETER	CONDITIONS	SYMBOL	MIN	ТҮР	MAX	UNIT
Static					•	
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250 \mu A$	BV <sub>DSS</sub>	600			V
Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, \ I_{\text{D}} = 250 \mu A$	V <sub>GS(TH)</sub>	2	3.4	4	V
Gate Body Leakage	$V_{GS} = \pm 30 V, V_{DS} = 0 V$	I <sub>GSS</sub>			±100	nA
Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	I <sub>DSS</sub>			1	μA
Drain-Source On-State Resistance (Note 4)	$V_{GS} = 10V, I_D = 2.1A$	R <sub>DS(on)</sub>		0.45	0.6	Ω
Dynamic (Note 5)					1	L
Total Gate Charge		Qg		13		
Gate-Source Charge	$V_{DS} = 380V, I_D = 7A,$	Q <sub>gs</sub>		3.36		nC
Gate-Drain Charge	$V_{GS} = 10V$	Q <sub>gd</sub>		5.56		1
Input Capacitance	$V_{DS} = 100V, V_{GS} = 0V,$	C <sub>iss</sub>		516		_
Output Capacitance	f = 1.0MHz	C <sub>oss</sub>		55		pF
Gate Resistance	F = 1MHz, open drain	R <sub>g</sub>		3.2		Ω
Switching (Note 6)						
Turn-On Delay Time		t <sub>d(on)</sub>		20.8		
Turn-On Rise Time	$V_{DD} = 380V,$	tr		10		
Turn-Off Delay Time	$R_{GEN} = 25\Omega,$ $I_D = 7A, V_{GS} = 10V$	t <sub>d(off)</sub>		43		ns
Turn-Off Fall Time	$I_D = I A, V_{GS} = 10V$	t <sub>f</sub>		8.4		
Source-Drain Diode						
Forward Voltage (Note 4)	$I_{\rm S} = 7 {\rm A}, \ V_{\rm GS} = 0 {\rm V}$	V <sub>SD</sub>			1.4	V
Reverse Recovery Time	V <sub>B</sub> = 100V, I <sub>S</sub> = 7A	t <sub>rr</sub>		232.5		ns
Reverse Recovery Charge	dl <sub>F</sub> /dt = 100A/µs	Q <sub>rr</sub>		2.16		μC

Notes:

1. Current limited by package.

2. Pulse width limited by the maximum junction temperature.

3. L = 50mH, I\_{AS} = 1.2A, V\_{DD} = 50V, R\_G = 25 $\Omega$ , Starting T\_J = 25 $^{o}C$ 

4. Pulse test: PW  $\leq$  300µs, duty cycle  $\leq$  2%.

5. For DESIGN AID ONLY, not subject to production testing.

6. Switching time is essentially independent of operating temperature.

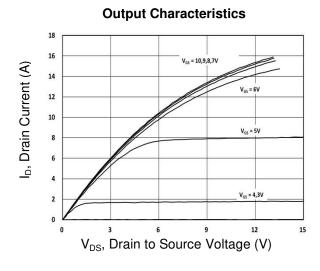
#### **ORDERING INFORMATION**

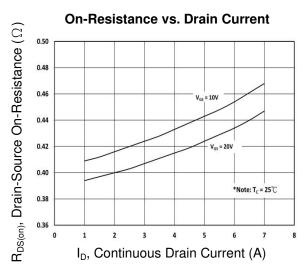
PART NO.	PACKAGE	PACKING	
TSM60NB600CH C5G	TO-251 (IPAK)	75pcs / Tube	



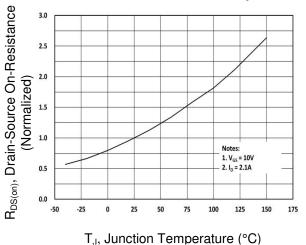
#### **CHARACTERISTICS CURVES**

 $(T_c = 25^{\circ}C \text{ unless otherwise noted})$ 



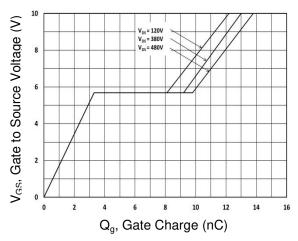


**On-Resistance vs. Junction Temperature** 

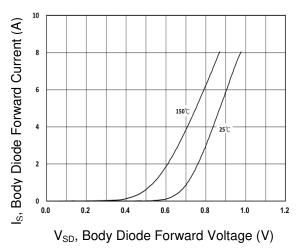


Transfer Characteristics

Gate-Source Voltage vs. Gate Charge



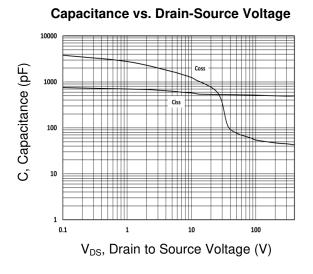
Source-Drain Diode Forward Current vs. Voltage



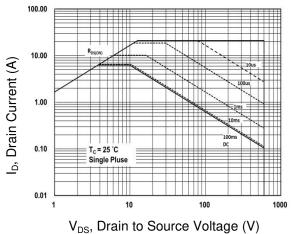


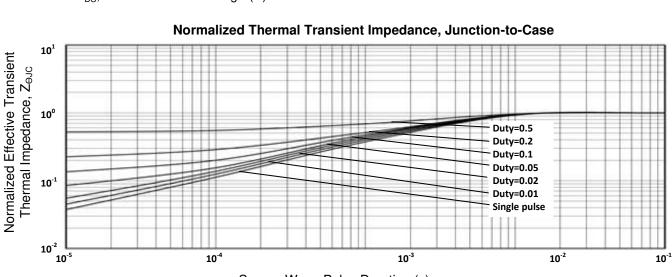
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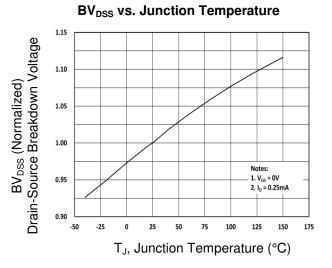


#### Maximum Safe Operating Area





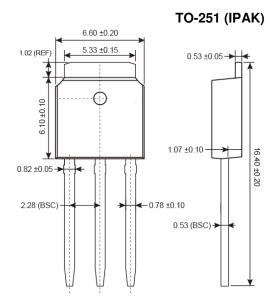


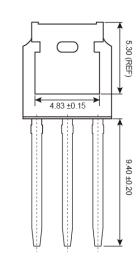




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### PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)





#### **MARKING DIAGRAM**

	Y	= `
55 60NB600 YML	М	= [
1000	L	= L

#1

( = )	Year	Code
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= Month Code for Halogen Free Product

<b>O</b> =Jan	P =Feb	<b>Q</b> =Mar	<b>R</b> =Apr
<b>S</b> =May	<b>T</b> =Jun	<b>U</b> =Jul	V =Aug
W =Sep	X =Oct	Y =Nov	<b>Z</b> =Dec

L = Lot Code (1~9, A~Z)



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